ET3DV6 SN:1788

September 30, 2004

## DASY - Parameters of Probe: ET3DV6 SN:1788

Sensitivity in Free Space <sup>A</sup>			Diode C	ompression <sup>8</sup>
NormX	1.68 ± 9.9%	$\mu V/(V/m)^2$	DCP X	<b>94</b> mV
NormY	1.70 ± 9.9%	$\mu V/(V/m)^2$	DCP Y	94 mV
NormZ	1.74 ± 9.9%	$\mu V/(V/m)^2$	DCP Z	94 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

## **Boundary Effect**

TSL	900 MHz	Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>be</sub> [%]	Without Correction Algorithm	8.1	4.4
SAR <sub>be</sub> [%]	With Correction Algorithm	0.7	0.1

TSL 1810 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>be</sub> [%]	Without Correction Algorithm	12.0	8.2
SAR <sub>be</sub> [%]	With Correction Algorithm	0.9	0.1

#### Sensor Offset

Probe Tip to Sensor Center 2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ET3-1788\_Sep04

A The uncertainties of NormX,Y,Z do not affect the E2-field uncertainty inside TSL (see Page 8).

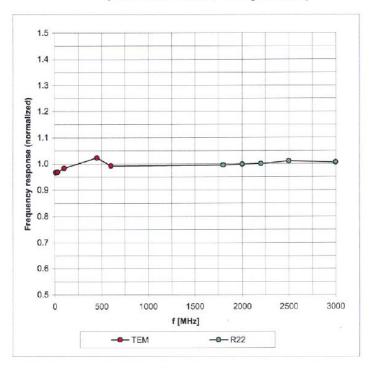
<sup>&</sup>lt;sup>8</sup> Numerical linearization parameter: uncertainty not required.

ET3DV6 SN:1788

September 30, 2004

## Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

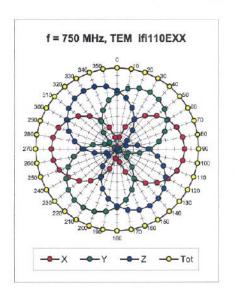
Certificate No: ET3-1788\_Sep04

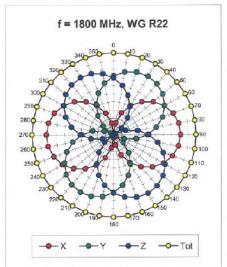
Page 5 of 9

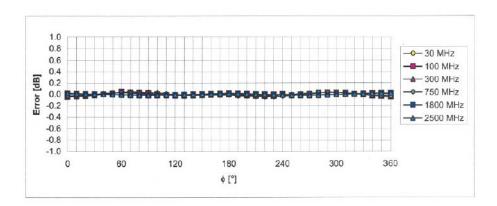
ET3DV6 SN:1788

September 30, 2004

# Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$







Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Certificate No: ET3-1788\_Sep04

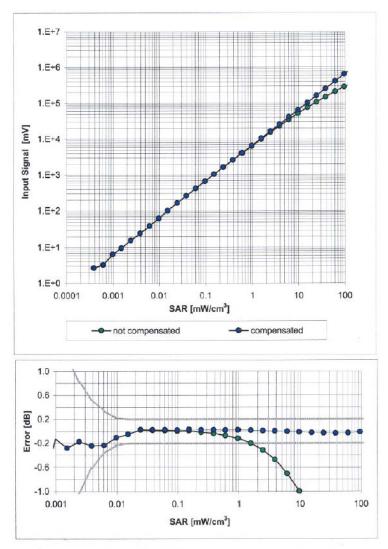
Page 6 of 9

ET3DV6 SN:1788

September 30, 2004

# Dynamic Range f(SAR<sub>head</sub>)

(Waveguide R22, f = 1800 MHz)



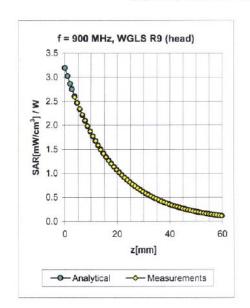
Uncertainty of Linearity Assessment: ± 0.6% (k=2)

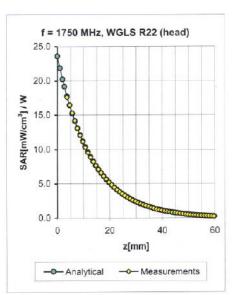
Certificate No: ET3-1788\_Sep04

#### ET3DV6 SN:1788

September 30, 2004

## **Conversion Factor Assessment**





f [MHz]	Validity [MHz] <sup>C</sup>	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	±50/±100	Head	41.5 ± 5%	0.90 ± 5%	1.12	1.42	6.74 ± 11.0% (k=2)
900	±50/±100	Head	41.5 ± 5%	0.97 ± 5%	1.07	1.44	6.63 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.56	2.31	5.37 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	$40.0 \pm 5\%$	1.40 ± 5%	0.55	2.42	5.16 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.54	2.59	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.65	2.22	4.56 ± 11.8% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	1.04	1.52	6.53 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.99	1.56	6.17 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.74	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.55	2.82	4.56 ± 11.0% (k=2)
2000	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.98	4.43 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.72	2.00	4.26 ± 11.8% (k=2)

<sup>&</sup>lt;sup>C</sup> The validity of ± 100 MHz only applies for DASY 4.3 B17 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Certificate No: ET3-1788\_Sep04

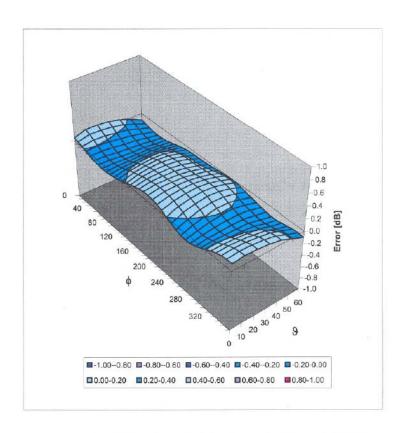
Page 8 of 9

ET3DV6 SN:1788

September 30, 2004

## Deviation from Isotropy in HSL

Error ( $\phi$ ,  $\vartheta$ ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)



Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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С

Client Sporton (Auden)

Certificate No: DAE3-577\_Nov04

SALIBITATION	ERTIFICATE		
Object	DAE3 - SD 000 D	03 AA - SN: 577	
Calibration procedure(s)	QA CAL-06.v10 Calibration proces	dure for the data acquisition unit (	DAE)
Calibration date:	November 17, 200	04	
Condition of the calibrated item	In Tolerance		
		r facility: environment temperature (22 ± 3)°C	and numidity < 70%.
Calibration Equipment used (M&T)	E critical for calibration)		
Primary Standards	ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	2 SN: 6295803	7-Sep-04 (Sintrel, No.E-040073)	Sep-05
Secondary Standards	lip#	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1002		In house check Jul-05
	Name	Function	Signature
Calibrated by:	Eric Hainfeld	Technician	
		R&D Director	iV. On talar
Approved by:	Fin Bomholt		1. V. Ul. Zalas
Approved by:	Fin Bomholt		Issued: November 17, 2004

Certificate No: DAE3-577\_Nov04 Page 1 of 5



### Calibration Laboratory of

Schmid & Partner Engineering AG Zoughausstrasse 43, 8004 Zurich, Switzerland



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Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

## Glossary

DAE digital acquisition electronics

Connector angle information used in DASY system to align probe sensor X to the robot

coordinate system.

#### Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
- Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
- AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
- Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
- Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
- Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
- Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE3-577\_Nov04

Page 2 of 5



## DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB =  $6.1\mu V$ , Low Range: 1LSB = 61nV,

full range = -100...+300 mV full range = -1......+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	х	Y	z
High Range	404.437 ± 0.1% (k=2)	403.891 ± 0.1% (k=2)	404.359 ± 0.1% (k=2)
Low Range	3.94121 ± 0.7% (k=2)	3.89867 ± 0.7% (k=2)	3.95408 ± 0.7% (k=2)

## **Connector Angle**

Connector Angle to be used in DASY system	127 ° ± 1 °
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Certificate No: DAE3-577\_Nov04

Page 3 of 5

## Appendix

1. DC Voltage Linearity

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	200000.6	0.00
Channel X	+ Input	20000	20001.77	0.01
Channel X	- Input	20000	-19991.81	-0.04
Channel Y	+ Input	200000	199999.7	0.00
Channel Y	+ Input	20000	19999.20	0.00
Channel Y	- Input	20000	-19994.82	-0.03
Channel Z	+ Input	200000	200000.2	0.00
Channel Z	+ Input	20000	19996.22	-0.02
Channel Z	- Input	20000	-19996.74	-0.02

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	200.05	0.03
Channel X - Input	200	-200.88	0.44
Channel Y + Input	2000	1999.9	0.00
Channel Y + Input	200	199.73	-0.13
Channel Y - Input	200	-200.53	0.27
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	199.25	-0.38
Channel Z - Input	200	-201.42	0.71

### 2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.15	12.30
	- 200	-12.61	-12.86
Channel Y	200	-7.43	-7.53
	- 200	6.30	6.52
Channel Z	200	-0.16	0.31
	- 200	-1.51	-1.48

## 3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.90	-0.22
Channel Y	200	1.47	-	4.60
Channel Z	200	-1.40	-0.08	-

Certificate No: DAE3-577\_Nov04

Page 4 of 5

#### 4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15948	15814
Channel Y	15960	16073
Channel Z	16236	16172

#### 5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.03	-3.07	1.24	0.58
Channel Y	-0.66	-2.19	1.96	0.55
Channel Z	-0.91	-2.82	0.42	0.39

### 6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

iiput itesistanee		
	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	199.3
Channel Y	0.2000	200.4
Channel Z	0.2001	199.5

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

10. Common Mode Bit Generation (verified during pre test)

Typical values	Bit set to High at Common Mode Error (VDC)	
Channel X, Y, Z	+1.25	

Certificate No: DAE3-577\_Nov04